

<b>Notice of References Cited</b>	Application/Control No. 09/825,323	Applicant(s)/Patent Under Reexamination LEIMER ET AL.	
	Examiner Hanh Nguyen	Art Unit 2662	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,160,803	12-2000	Yuen et al.	370/342
	B	US-6,064,663	05-2000	Honkasalo et al.	370/335
	C	US-6,504,833 B1	01-2003	Ishii et al.	370/342
	D	US-6,775,254 B1	08-2004	Willenegger et al.	370/329
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.